

Notice of References Cited	Application/Control No. 10/781,523	Applicant(s)/Patent Under Reexamination SUNDARAM ET AL.	
	Examiner Jerome Jackson Jr.	Art Unit 2815	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0167984	11-2002	Scherer, Axel	372/50
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Temelkuran et al "Photonic...detectros" IQEC '98 pp.80-81, 3-8 May 1998
	V	Krauss et al "Fabrication..." Electr. Lett.Vol.30 No.17 pp.1444-1446 18 August 1994
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.